MEMORY cmos

2 × 1M × 8 BITS SYNCHRONOUS DYNAMIC RAM

MB81117822A-125/-100/-84/-67

CMOS 2 Banks of 1,048,576-WORDS \times 8 BITS Synchronous Dynamic Random Access Memory

■ DESCRIPTION

The Fujitsu MB81117822A is a CMOS Synchronous Dynamic Random Access Memory (SDRAM) containing 16,777,216 memory cells accessible in an 8-bit format. The MB81117822A features a fully synchronous operation referenced to a positive edge clock whereby all operations are synchronized at a clock input which enables high performance and simple user interface coexistence. The MB81117822A SDRAM is designed to reduce the complexity of using a standard dynamic RAM (DRAM) which requires many control signal timing constraints, and may improve data bandwidth of memory as much as 5 times more than a standard DRAM.

The MB81117822A is ideally suited for laser printers, high resolution graphic adapters, accelerators and other applications where an extremely large memory and bandwidth are required and where a simple interface is needed.

■ PRODUCT LINE & FEATURES

Parameter		MB81117822A							
raiametei	-125	-100	-84	-67					
Clock Frequency	125 MHz max.	100 MHz max.	84 MHz max.	67 MHz max.					
Burst Mode Cycle Time	8 ns min.	10 ns min.	12 ns min.	15 ns min.					
RAS Access Time	45 ns max.	54 ns max.	56 ns max.	60 ns max.					
CAS Access Time	21 ns max.	24 ns max.	26 ns max.	30 ns max.					
Access Time from Clock (CL = 3)	7.5 ns max.	8.5 ns max.	8.5 ns max.	9 ns max.					
Operating Current (Two banks active)	140 mA max.	130 mA max.	120 mA max.	110 mA max.					
Power Down Mode Current	2 mA max.								

- Single +3.3 V Supply ±0.3 V tolerance
- LVTTL compatible I/O
- 2 K refresh cycles every 32.8 ms
- · Dual bank operation
- Byte control by DQM
- Burst read/write operation and burst read/single write operation capability

- Programmable burst type, burst length, and CAS latency
- Auto-and Self-refresh (every 16 μs)
- CKE power down mode
- Output Enable and Input Data Mask

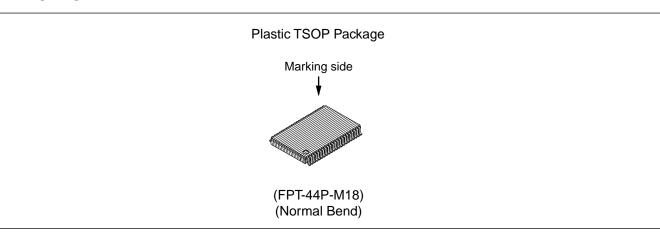
This device contains circuitry to protect the inputs against damage due to high static voltages or electric fields. However, it is advised that normal precautions be taken to avoid application of any voltage higher than maximum rated voltages to this high impedance circuit.

■ ABSOLUTE MAXIMUM RATINGS (See WARNING)

Parameter	Symbol	Value	Unit
Voltage of Vcc Supply Relative to Vss	Vcc, Vccq	-0.5 to +4.6	V
Voltage at Any Pin Relative to Vss	VIN, VOUT	-0.5 to +4.6	V
Short Circuit Output Current	Іоит	±50	mA
Power Dissipation	P _D	1.3	W
Storage Temperature	Тѕтс	-55 to +125	°C

WARNING: Permanent device damage may occur if the above **Absolute Maximum Ratings** are exceeded. Functional operation should be restricted to the conditions as detailed in the operational sections of this data sheet. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

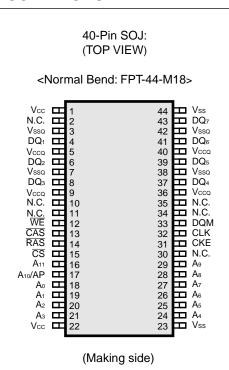
■ PACKAGE



Package and Ordering Information

- 44-pin plastic (400 mil) TSOP-II, order as MB81117822A-XXXFN (2K Refresh)

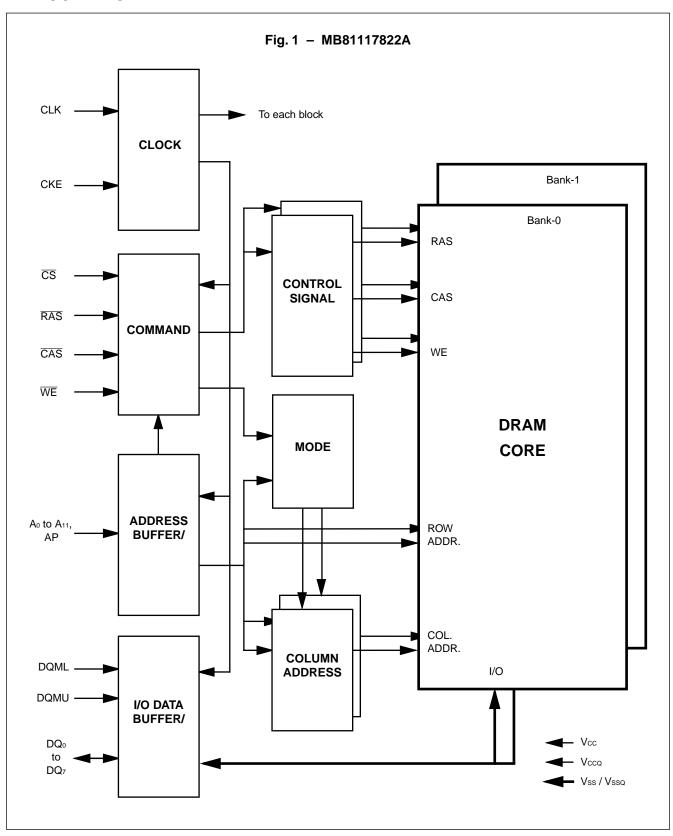
■ PIN ASSIGNMENTS AND DESCRIPTIONS



Pin Number	Symbol	Function				
1, 5, 9, 22, 36, 40	Vcc, Vccq	Supply Voltage				
4, 8, 37, 39, 41, 43,	DQ ₀ to DQ ₇	Data I/O				
3, 7, 23, 38, 42, 44	Vss, Vssq*	Ground				
10, 11, 30, 34, 35	N.C.	No Connection				
12	WE	Write Enable				
13	CAS	Column Address Strobe				
14	RAS	Row Address Strobe				
15	CS	Chip Select				
16	A ₁₁ (BA)	Bank Select				
17	AP	Auto Precharge Enable				
17, 18, 19, 20, 21, 24, 25, 26, 27, 28, 29	A ₀ to A ₁₀	Address Input • Row : A ₀ to A ₁₀ • Column : A ₀ to A ₈				
31	CKE	Clock Enable				
32	CLK	Clock Input				
33	DQM	Input Mask/Output Enable				

^{*:} These pins are connected internally in the chip.

■ BLOCK DIAGRAM



■ FUNCTION TRUTH TABLE

COMMAND TRUTH TABLE

Function	Notes	Symbol	CI	KE	CS	RAS	CAS	WE	A 11	A 10	A ₉ to	A ₇ to
i diletion	Notes	Symbol	n-1	n		INAG	CAG	***	(BA)	(AP)	A 8	Ao
Device Deselect	*5	DESL	Н	Х	Н	Х	Х	Х	Х	Х	Х	Х
No Operation	*5	NOP	Н	Х	L	Н	Н	Н	Х	Х	Х	Х
Burst Stop	*6	BST	Н	Х	L	Н	Н	L	Х	Х	Х	Х
Read	*7	READ	Н	Х	L	Н	L	Н	V	L	Х	V
Read with Auto-precharge	*7	READA	Н	Х	L	Н	L	Н	V	Н	Х	V
Write	*7	WRIT	Н	Х	L	Н	L	L	V	L	Х	V
Write with Auto-precharge	*7	WRITA	Н	Х	L	Н	L	L	V	Н	Х	V
Bank Active (RAS)	*8	ACTV	Н	Х	L	L	Н	Н	V	V	V	V
Precharge Single Bank		PRE	Н	Х	L	L	Н	L	V	L	Χ	Х
Precharge All Banks		PALL	Н	Х	L	L	Н	L	Х	Н	Х	Х
Mode Register Set	*9,10	MRS	Н	Х	L	L	L	L	V	L	V	V

Notes: *1. V = Valid, L = Logic Low, H = Logic High, X = either L or H.

- *2. All commands assumes no CSUS command on previous rising edge of clock.
- *3. All commands are assumed to be valid state transitions.
- *4. All inputs are latched on the rising edge of clock.
- *5. NOP and DESL commands have the same effect on the part.
- *6. BST command is effective only during full column burst read or write.
- *7. READ, READA, WRIT, and WRITA commands should only be issued after the corresponding bank has been activated (ACTV command). Refer to STATE DIAGRAM.
- *8. ACTV command should only be issued after corresponding bank has been precharged (PRE or PALL command).
- *9. Required after power up.
- *10. MRS command should only be issued after all banks have been precharged (PRE or PALL command). Refer to STATE DIAGRAM.

DQM TRUTH TABLE

Function	Command	CI	DQM	
Tunction	Command	n-1	n	DQIVI
Data Write/Output Enable	ENBL	Н	X	L
Data Mask/Output Disable	MASK	Н	Х	Н

CKE TRUTH TABLE

Current	Function	Notos	Symbol	CI	KE	CS	RAS	CAS	WE	A 11	A 10	A ₉
State	Function	Notes	Symbol	n-1	n	CS	KAS	CAS	VVE	(BA)	(AP)	A ₀
Bank Active	Clock Suspend Mode Entry	*1	CSUS	Н	L	Х	Х	Х	Х	Х	Х	Х
Any	Clock Suspend Continue	*1		L	L	Х	Х	Х	Х	Х	Х	Х
Clock Suspend	Clock Suspend Mode Exit			L	Н	Х	Х	Х	Х	Х	х	Х
Idle	Auto-refresh Command	*2	REF	Н	Н	L	L	L	Н	Х	Х	Х
Idle	Self-refresh Entry	*2	SELF	Н	L	L	L	L	Н	Х	Х	Х
Self Refresh	Self-refresh Exit		SELFX	L	Н	L	Н	Н	Н	Х	Х	Х
Sell Kellesii	Sell-lellesii Exit		CLLIX	L	Н	Н	Х	Х	Х	Х	Х	Х
Idle	Power Down Entry		PD	Н	L	L	Н	Н	Н	Х	Х	Х
luie	Power Down Linny			Н	L	Н	Х	Х	Х	Х	Х	Χ
Precharge	Power Down Entry		PD	Н	L	L	Н	Н	Н	Х	Х	Χ
riecharge	Power Down Linny			Н	L	Н	Х	Х	Х	Х	Х	Χ
Bank Active	Power Down Entry	*3	PD	Н	L	L	L	Н	L	V	L	Χ
Dalik Active	Fower Down Entry	3	50	Н	L	L	L	Н	L	Х	Н	Χ
Power Down	Power Down Exit			L	Н	L	Н	Н	Н	Х	Х	Х
I OWEL DOWN	TOWER DOWN EXIL			L	Н	Н	Х	Х	Х	Х	Х	Х

Notes: *1. The CSUS command requires that at least one bank is active. Refer to STATE DIAGRAM.

^{*2.} REF and SELF commands should only be issued after all banks have been precharged (PRE or PALL command). Refer to STATE DIAGRAM.

^{*3.} PD command should be issued after all banks have been precharged (PRE or PALL command). If a bank or all banks are in active state, PD command can be issued in conjuction with PRE or PALL command whichever precharge command makes all banks in idle state.

OPERATION COMMAND TABLE (Applicable to single bank)

Current State	cs	RAS	CAS	WE	Addr	Command	Function Notes
Idle	Н	Х	Х	Х	Х	DESL	NOP
	L	Н	Н	Н	Х	NOP	NOP
	L	Н	Н	L	Х	BST	NOP
	L	Н	L	Н	BA, CA, AP	READ/READA	Illegal
	L	Н	L	L	BA, CA, AP	WRIT/WRITA	Illegal
	L	L	Н	Н	BA, RA	ACTV	Bank Active after tRCD
	L	L	Н	L	BA, AP	PRE/PALL	NOP
	L	L	L	Н	Х	REF/SELF	Auto-refresh or Self-refresh *3
	L	L	L	L	MODE	MRS	Mode Register Set (Idle after trsc) *3
Bank Active	Н	Х	Х	Х	Х	DESL	NOP
	L	Н	Н	Н	Х	NOP	NOP
	L	Н	L	Н	BA, CA, AP	READ/READA	Begin Read: Determine AP
	L	Н	Н	L	Х	BST	NOP
	L	Н	L	L	BA, CA, AP	WRIT/WRITA	Begin Write: Determine AP
	L	L	Н	Н	BA, RA	ACTV	Illegal *2
	L	L	Н	L	BA, AP	PRE/PALL	Precharge: Determine Precharge Type
	L	L	L	Н	Х	REF/SELF	Illegal
	L	L	L	L	MODE	MRS	Illegal

Current State	CS	RAS	CAS	WE	Addr	Command	Function Notes
Read	Н	Х	Х	Х	Х	DESL	NOP (Continue Burst to End → Bank Active)
	L	Н	Н	Н	Х	NOP	NOP (Continue Burst to End \rightarrow Bank Active)
	L	Н	Н	L	х	BST	Burst Stop → Bank Active (BL = Full Column) NOP (BL = 1, 2, 4, 8)
	L	Н	L	Н	BA, CA, AP	READ/READA	Terminate Burst, New Read ; Determine AP
	L	Н	L	L	BA, CA, AP	WRIT/WRITA	Terminate Burst, Start Write ; *4
	L	L	Н	Н	BA, RA	ACTV	Illegal *2
	L	L	Н	L	BA, AP	PRE/PALL	Terminate Burst, Precharge ; Determine Precharge Type
	L	L	L	Н	Х	REF/SELF	Illegal
	L	L	L	L	MODE	MRS	Illegal
Write	Н	Х	х	Х	Х	DESL	NOP (Continue Burst to End → Write Recovering)
	L	Н	Н	Н	Х	NOP	NOP (Continue Burst to End → Write Recovering)
	L	Н	Н	L	Х	BST	Burst Stop → Write Recovering → Bank Active (BL = Full Column) NOP (BL = 1, 2, 4, 8)
	L	Н	L	Н	BA, CA, AP	READ/READA	Terminate Burst, Start Read ; Determine AP
	L	Н	L	L	BA, CA, AP	WRIT/WRITA	Terminate Burst, New Write ; Determine AP *4
	L	L	Н	Н	BA, RA	ACTV	Illegal *2
	L	L	Н	L	BA, AP	PRE/PALL	Terminate Burst, Precharge ; Determine Precharge Type *4
	L	L	L	Н	Х	REF/SELF	Illegal
	L	L	L	L	MODE	MRS	Illegal

Current State	CS	RAS	CAS	WE	Addr	Command	Function Notes
Read with Auto- precharge	Н	Х	Х	Х	Х	DESL	NOP (Continue Burst to End → Precharge)
precharge	L	Н	Н	Н	Х	NOP	NOP (Continue Burst to End → Precharge)
	L	Н	Н	L	Х	BST	Illegal
	L	Н	L	Н	BA, CA, AP	READ/READA	Illegal *2
	L	Н	L	L	BA, CA, AP	WRIT/WRITA	Illegal *2
	L	L	Н	Н	BA, RA	ACTV	Other Bank Active, Illegal on Same Bank
	L	L	Н	L	BA, AP	PRE/PALL	Illegal *2
	L	L	L	Н	Х	REF/SELF	Illegal
	L	L	L	L	MODE	MRS	Illegal
Write with Auto- precharge	Н	Х	Х	Х	Х	DESL	NOP (Continue Burst to End → Write Recovering with Precharge)
proonargo	L	Н	Н	Н	Х	NOP	NOP (Continue Burst to End → Write Recovering with Precharge)
	L	Н	Н	L	Х	BST	Illegal
	L	Н	L	Н	BA, CA, AP	READ/READA	Other Bank Active, Illegal on Same Bank
	L	н	L	L	BA, CA, AP	WRIT/WRITA	Other Bank Active, Illegal on Same Bank
	L	L	Н	Н	BA, RA	ACTV	Illegal *2
	L	L	Н	L	BA, AP	PRE/PALL	Illegal *2
	L	L	L	Н	Х	REF/SELF	Illegal
	L	L	L	L	MODE	MRS	Illegal

Current State	CS	RAS	CAS	WE	Addr	Command	Function Notes
Precharge	Н	Х	Х	Х	Х	DESL	NOP (Idle after trp)
	L	Н	Н	Н	Х	NOP	NOP (Idle after t _{RP})
	L	Н	Н	L	Х	BST	Illegal
	L	Н	L	Н	BA, CA, AP	READ/READA	Illegal *2
	L	Н	L	L	BA, CA, AP	WRIT/WRITA	Illegal *2
	L	L	Н	Н	BA, RA	ACTV	Illegal *2
	L	L	Н	L	BA, AP	PRE/PALL	NOP (PALL May affect Other Bank) *5
	L	L	L	Н	Х	REF/SELF	Illegal
	L	L	L	L	MODE	MRS	Illegal
Bank	Н	Х	Х	Х	Х	DESL	NOP (Bank Active after tRCD)
Activating	L	Н	Н	Н	Х	NOP	NOP (Bank Active after tRCD)
	L	Н	Н	L	Х	BST	NOP (Bank Active after tRCD)
	L	Н	L	Н	BA, CA, AP	READ/READA	Illegal *2
	L	Н	L	L	BA, CA, AP	WRIT/WRITA	Illegal *2
	L	L	Н	Н	BA, RA	ACTV	Illegal *6
	L	L	Н	L	BA, AP	PRE/PALL	Illegal *2
	L	L	L	Н	Х	REF/SELF	Illegal
	L	L	L	L	MODE	MRS	Illegal

Current State	<u>cs</u>	RAS	CAS	WE	Addr	Command	Function Notes
Write Recovering	Н	Х	Х	Х	Х	DESL	NOP (Bank Active after twr/tbwc)
Recovering	L	Н	Н	Н	Х	NOP	NOP (Bank Active after twr/tbwc)
	L	Н	Н	L	Х	BST	NOP (Bank Active after twr/tbwc)
	L	Н	L	Н	BA, CA, AP	READ/READA	Start Read; Determine AP *4
	L	Н	L	L	BA, CA, AP	WRIT/WRITA	New Write; Determine AP
	L	L	Н	Н	BA, RA	ACTV	Illegal *2
	L	L	Н	L	BA, AP	PRE/PALL	Illegal *2
	L	L	L	Н	Х	REF/SELF	Illegal
	L	L	L	L	MODE	MRS	Illegal
Write Recovering	Н	Х	Х	Х	Х	DESL	NOP (Precharge after trwL/tbwL)
with Auto-	L	Н	Н	Н	Х	NOP	NOP (Precharge after trwL/tbwL)
precharge	L	Н	Н	L	Х	BST	Illegal
	L	Н	L	Н	BA, CA, AP	READ/READA	Illegal *2
	L	Н	L	L	BA, CA, AP	WRIT/WRITA	Illegal *2
	L	L	Н	Н	BA, RA	ACTV	Illegal *2
	L	L	Н	L	BA, AP	PRE/PALL	Illegal *2
	L	L	L	Н	Х	REF/SELF	Illegal
	L	L	L	L	MODE	MRS	Illegal

(Continued)

Current State	cs	RAS	CAS	WE	Addr	Command	Function Notes
Refreshing	Н	Х	Х	Х	Х	DESL	NOP (Idle after t _{RC})
	L	Н	Н	Х	Х	NOP/BST	NOP (Idle after t _{RC})
	L	Н	L	Х	Х	READ/READA WRIT/WRITA	Illegal
	L	L	Н	Х	Х	ACTV/ PRE/PALL	Illegal
	L	L	L	Х	Х	REF/SELF MRS	Illegal *6
Mode Register	Н	Х	Х	Х	Х	DESL	NOP (Idle after t _{RSC})
Setting	L	Н	Н	Н	Х	NOP	NOP (Idle after trsc)
	L	Н	Н	L	Х	BST	Illegal
	L	Н	L	Х	Х	READ/READA WRIT/WRITA	Illegal
	L	L	Х	Х	Х	ACTV PRE/PALL REF/SELF MRS	Illegal

ABBREVIATIONS:

RA = Row Address BA = Bank Address CA = Column Address AP = Auto Precharge

COMMAND TRUTH TABLE FOR CKE

Current State	CKE n-1	CKE n	cs	RAS	CAS	WE	Addr	Function Notes			
Self Refresh	Н	Х	Н	Х	Х	Х	Х	Invalid			
Keilesii	L	Н	Н	Х	Х	Х	Х	Exit Self Refresh, Idle after tRC			
	L	Н	L	Н	Н	Н	Х	Exit Self Refresh, Idle after tRC			
	L	Н	L	Н	L	Х	Х	Illegal			
	L	Н	L	L	Х	Х	Х	Illegal			
	L	L	Х	Х	Х	Х	Х	NOP (Maintain Self Refresh)			
Self Refresh	Н	Н	Н	Х	Х	Х	Х	Idle after tRC			
Recovery	Н	Н	L	Н	Н	Х	Х	Idle after tRC			
	Н	Н	L	Н	L	Х	Х	Illegal			
	Н	Н	L	L	Х	Х	Х	Illegal			
	Н	L	Н	Х	Х	Х	Х	Begin Clock Suspend Next Cycle			
	Н	L	L	Н	Н	Х	Х	Begin Clock Suspend Next Cycle			
	Н	L	L	Н	L	Х	Х	Illegal			
	Н	L	L	L	Х	Х	Х	Illegal			
	L	Н	Х	Х	Х	Х	Х	Exit Clock Suspend Next Cycle			
	L	L	Х	Х	Х	Х	Х	Maintain Clock Suspend			

Current State	CKE n-1	CKE n	cs	RAS	CAS	WE	Addr	Function Notes			
Power Down	Н	Х	Х	Х	Х	Х	_	Invalid			
Down		Н	Н	Х	Х	Х	Х	Exit Power Down Mode → Idle			
	L	П	L	Н	Н	Н	Х	Exit Fower Down Mode → Idie			
	L	L	Х	Х	Х	Х	Х	NOP (Maintain Power Down Mode)			
	L	Н	L	L	Х	Х	Х	Illegal			
	L	Н	L	Н	L	Х	Х	Illegal			
Both Banks	Н	Н	Н	Х	Х	Х	_	Refer to the Operation Command Tab			
Idle	Н	Н	L	Н	Х	Х	_	Refer to the Operation Command Table			
	Н	Н	L	L	Н	Х	_	Refer to the Operation Command Table			
	Н	Н	L	L	L	Н	Х	Auto-refresh			
	Н	Н	L	L	L	L	SPECIAL MODE	Refer to the Operation Command Table			
	Н	Н	L	L	L	L	MODE	Refer to the Operation Command Table			
	Н	L	Н	Х	Х	Х	_	Refer to the Operation Command Table			
	Н	L	L	Н	Х	Х	_	Refer to the Operation Command Table			
	Н	L	L	Н	Х	Х	_	Refer to the Operation Command Table			
	Н	L	L	L	L	Н	Х	Self-refresh			
	Н	L	L	L	L	L	SPECIAL MODE	Refer to the Operation Command Table			
	Н	L	L	L	L	L	MODE	Refer to the Operation Command Table			
	L	Х	Х	Х	Х	Х	Х	Power Down			

(Continued)

Current State	CKE n-1	CKE n	CS	RAS	CAS	WE	Addr	Function Notes				
Bank Active Bank	Н	Х	Х	Х	Х	Х	Х	Refer to the Operation Command Table				
Activeting Read/Write	L	Н	Х	Х	Х	Х	Х	Begin Clock Suspend Next Cycle				
	L	Н	Х	Х	Х	Н	Х	Exit Clock Suspend Next Cycle				
	L	Н	Х	Х	Х	Х	Х	Maintain Clock Suspend				
Clock Suspend	Н	Н	Х	Х	Х	Х	Х	Invalid				
Suspend	L	Н	Х	Х	Х	Х	Х	Exit Clock Suspend Next Cycle				
	L	Н	Х	Х	Х	Х	Х	Maintain Clock Suspend				
Any State Other Than	Н	Н	Х	Х	Х	Х	Х	Refer to the Operation Command Table				
Listed Above	Н	L	Х	Х	Х	Х	Х	Begin Clock Suspend Next Cycle				
1.3000	L	Н	Х	Х	Х	Х	Х	Exit Clock Suspend Next Cycle				
	L	L	Х	Х	Х	Х	Х	Maintain Clock Suspend				

Notes: *1. All entries assume the CKE was High during the proceeding clock cycle and the current clock cycle.

- *2. Illegal to bank in specified state; entry may be legal in the bank specified by BA, depending on the state of that bank.
- *3. Illegal if any bank is not idle.
- *4. Must satisfy bus contention, bus turn around, and/or write recovery requirements.
- *5. NOP to bank precharging or in idle state. May precharge bank spesified by BA (and AP).
- *6. trrd must be satisfied for other bank.

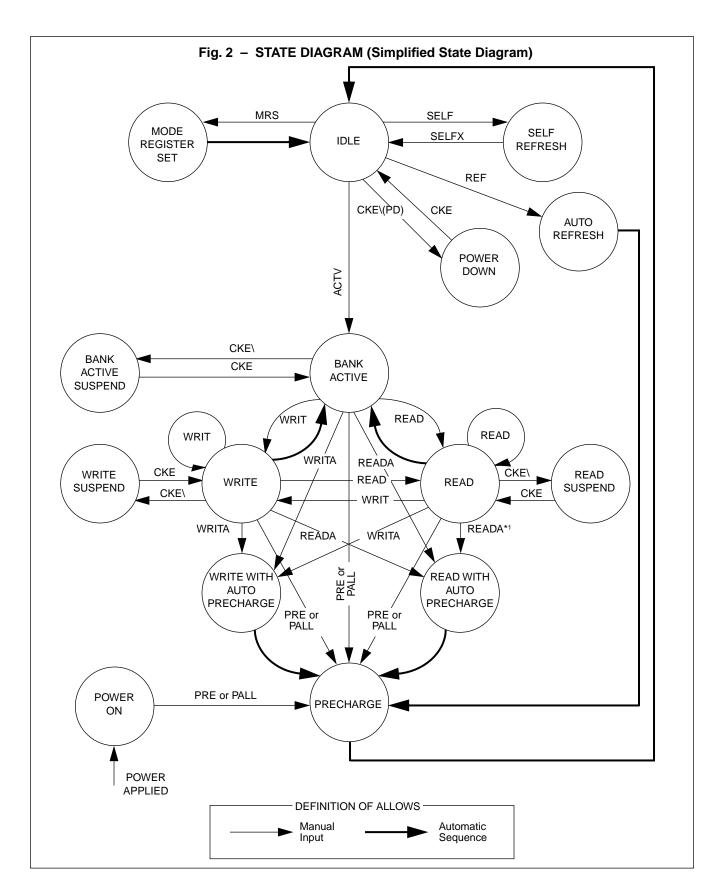
CLOCK LATENCY OR DELAY TIME FOR 2 BANK OPERATION

Second command (opposite bank) First command	MRS	ACTV	READ	READA	WRT	WRITA	PRE	PALL	REF	SELF
MRS	I MRD	I MRD							I MRD	İmrd
ACTV		*1 t RRD	*2 1	1	1	*2 1	1	t ras		
READ		*1 1	*2 1	1	*2 *3	*2 *3 1	1	1		
READA		*1 1	*2 1	1	*2 *3	*2 *3 1	1	1	*1 BL + t _{RP}	*1 *4 BL + t _{RP}
WRIT		*1 1	*2 1	1	*2 1	*2 1	1	1		
WRITA		*1 1	*2 1	1	*2 1	*2 1	1	1	BL + 1 + t _{RP}	BL + 1 + t _{RP}
PRE	*1 t RP	*1 1	*2 1	1	*2 1	*2 1	1	1	*1 t RP	*1 t RP
PALL *5	t RP	*1 1					1	1	*1 *6 t RP	*1 *6 t RP
REF	t RC	t RC							t rrd	t RC
SELF	tpde + trc	tpde + trc							tpde + trc	tpde + trc

Notes: *1. Assume opposite bank is in idle state.

- *2. Assume opposite bank is in active state.
- *3. Assume no I/O conflict.
- *4. If $t_{RP} \leftarrow t_{CK}$, minimum latency is a sum of BL + CL.
- *5. Assume PALL command dose not affect any operation on opposite bank.
- *6. Assume Output is in High-Z state.

Illegal Command



■ FUNCTIONAL DESCRIPTION

SDRAM BASIC FUNCTION

Three major differences between this SDRAM and conventional DRAMs are: synchronized operation, burst mode, and mode register.

The **synchronized operation** is the fundamental difference. An SDRAM uses a clock input for the synchronization, where the DRAM is basically asynchronous memory although it has been using two clocks, RAS and CAS. Each operation of DRAM is determined by their timing phase differences while each operation of SDRAM is determined by commands and all operations are referenced to a positive clock edge. Fig. 3 shows the basic timing diagram difference between SDRAMs and DRAMs.

The **burst mode** is a very high speed access mode utilizing an internal column address generator. Once a column addresses for the first access is set, following addresses are automatically generated by the internal column address counter.

The **mode register** is to justify the SDRAM operation and function into desired system conditions. Referenced in MODE REGISTER TABLE shows how SDRAM can be configured for system requirement by mode register programming.

CLOCK (CLK) and CLOCK ENABLE (CKE)

All input and output signals of SDRAM use register type buffers. A CLK is used as a trigger for the register and internal burst counter increment. All inputs are latched by a positive edge of CLK. All outputs are validated by the CLK. CKE is a high active clock enable signal. When CKE = Low is latched at a clock input during active cycle, the next clock will be internally masked. During idle state (All banks have been precharged.), CKE = Low enters the Power Down mode (standby) and this will make extremely low standby current.

CHIP SELECT (CS)

 $\overline{\text{CS}}$ enables all commands inputs, $\overline{\text{RAS}}$, $\overline{\text{CAS}}$, and $\overline{\text{WE}}$, and address input. When $\overline{\text{CS}}$ is High, command signals are negated but internal operation such as burst cycle will not be suspended. If such a control isn't needed, $\overline{\text{CS}}$ can be tied to ground level.

COMMAND INPUT (RAS, CAS and WE)

Unlike a conventional DRAM, \overline{RAS} , \overline{CAS} , and \overline{WE} do not directly imply SDRAM operation, such as Row address strobe by \overline{RAS} . Instead, each combination of \overline{RAS} , \overline{CAS} , and \overline{WE} input in conjunction with \overline{CS} input at a rising edge of the CLK determines SDRAM operation. Refer to FUNCTION TRUTH TABLE in Page 5.

ADDRESS INPUT (Ao to A10)

Address input selects an arbitrary location of a total of 1,048,576 words of each memory cell matrix. A total of twenty address input signals are required to decode such a matrix. SDRAM adopts an address multiplexer in order to reduce the pin count of the address line. At a Bank Active command (ACTV), eleven Row addresses are initially latched and the remainder of eight Column addresses are then latched by a Column address strobe command of either a Read command (READ or READA) or Write command (WRIT or WRITA).

BANK SELECT (A11)

This SDRAM has two banks and each bank is organized as 1M words by 8-bit.

Bank selection by A₁₁ occurs at Bank Active command (ACTV) followed by read (READ or READA), write (WRIT or WRITA), and precharge command (PRE).

DATA INPUT AND OUTPUT (DQ₀ to DQ₇)

Input data is latched and written into memory at the clock followed by a write command input. Data output is obtained by the following conditions followed by a read command input:

trac : from the bank active command when tred (min) is satisfied. (This parameter is reference only.)

tcac : from the read command when tRCD is greater than tRCD (min).

tac : from the clock edge after trac and toac.

The polarity of the output data is identical to that of the input. Data is valid between access time (determined by the three conditions above) and the next positive clock edge (toh).

DATA I/O MASK (DQM)

DQM is an active high enable input and has an output disable and inputs mask function. During burst cycle and when DQM = High is latched by a clock, input is masked at the same clock and output will be masked at the second clock later while internal burst counter will increment by one or will go to the next stage depending on burst type.

BURST MODE OPERATION AND BURST TYPE

The burst mode provides faster memory access. The burst mode is implemented by keeping the same Row address and by automatic strobing column address. Access time and cycle time of Burst mode is specified as tac and tok, respectively. The internal column address counter operation is determined by a mode register which defines burst type and burst count length of 1,2 or 4 bits of boundary. In order to terminate or to move from the current burst mode to the next stage while the remaining burst count is more than 1, the following combinations will be required:

Current Stage	Next Stage	N	lethod (Assert the following command)					
Burst Read	Burst Read	Read Comma	nd					
Burst Read	Burst Write	1st Step	Mask Command (Normally 3 clock cycles)					
Buist Neau	buist write	2nd Step	Write Command after lowd					
Burst Write	Burst Write	Write Comma	nd					
Burst Write	Burst Read	Read Comma	nd					
Burst Read	Precharge	Precharge Co	Precharge Command					
Burst Write	Precharge	Precharge Co	mmand					

The burst type can be selected either sequential or interleave mode if burst length is 2 or 4. The sequential mode is an incremental decoding scheme within a boundary address to be determined by count length, it assigns+1 to the previous (or initial) address until reaching the end of boundary address and then wraps round to least significant address(= 0). The interleave mode is a scrambled decoding scheme for A_0 and A_2 . If the first access of column address is even (0), the next address will be odd (1), or vice-versa.

BURST MODE OPERATION AND BURST TYPE (Continued)

When the full burst operation is executed at single write mode, Auto-precharge command is valid only at write operation.

The burst type can be selected either sequential or interleave mode. But only the sequential mode is usable to the full column burst. The sequential mode is an incremental decoding scheme within a boundary address to be determined by burst length, it assigns +1 to the previous (or initial) address until reaching the end of boundary address and then wraps round to least significant address (= 0).

Burst Length	Stating Column Address A ₂ A ₁ A ₀	Sequential Mode	Interleave
2	X X 0	0 – 1	0 – 1
	X X 1	1 – 0	1 – 0
	X 0 0	0-1-2-3	0-1-2-3
4	X 0 1	1-2-3-0	1-0-3-2
4	X 1 0	2-3-0-1	2-3-0-1
	X 1 1	3-0-1-2	3-2-1-0
	0 0 0	0-1-2-3-4-5-6-7	0-1-2-3-4-5-6-7
	0 0 1	1-2-3-4-5-6-7-0	1-0-3-2-5-4-7-6
	0 1 0	2-3-4-5-6-7-0-1	2-3-0-1-6-7-4-5
8	0 1 1	3-4-5-6-7-0-1-2	3-2-1-0-7-6-5-4
0	1 0 0	4-5-6-7-0-1-2-3	4-5-6-7-0-1-2-3
	1 0 1	5-6-7-0-1-2-3-4	5-4-7-6-1-0-3-2
	1 1 0	6-7-0-1-2-3-4-5	6-7-4-5-2-3-0-1
	1 1 1	7-0-1-2-3-4-5-6	7-6-5-4-3-2-1-0

FULL COLUMN BURST AND BURST STOP COMMAND (BST)

The full column burst is an option of burst length and available only at sequential mode of burst type. This full column burst mode is repeatedly access to the same column. If burst mode reaches end of column address, then it wraps round to first column address (= 0) and continues to count until interrupted by the news read (READ)/write (WRIT/BWRIT), precharge (PRE), or burst stop (BST) command. The selection of auto-precharge option is illegal during the full column burst operation except write command at BURST READ & SINGLE WRITE mode.

The BST command is applicable to terminated the full column burst operation and illegal during the burst operation with length of 1, 2, 4, and 8. If the BST command is asserted during the full column burst mode, its operation is terminated immediately and the internal state moves to Bank Active.

When read mode is interrupted by BST command, the output will be in High-Z.

For the detail rule, please refer to Timing Diagram-8.

When write mode is interrupted by BST command, the data to be applied at the same time with BST command will be ignored.

BURST READ & SINGLE WRITE

The burst read and single write mode provides single word write operation regardless of its burst length. In this mode, burst read operation does not be affected by this mode.

PRECHARGE AND PRECHARGE OPTION (PRE, PALL)

SDRAM memory core is the same as DRAMs', requiring precharge and refresh operations. Precharge rewrites the bit line and to reset the internal Row address line and is executed by Precharge command (PRE). With the precharge command, SDRAM will automatically be in standby state after precharge time (trp).

The precharged bank is selected by combination of AP and A₁₁ when Precharge command is asserted.

If AP = High, both banks are precharged regardless of A_{11} (PALL). If AP = Low, a bank to be selected by A_{11} is precharged (PRE).

The auto-precharge enters precharge mode at the end of burst mode of read or write without Precharge command assertion.

This auto precharge is entered by AP = High when a read or write command is asserted. Refer to FUNCTION TRUTH TABLE.

AUTO-REFRESH (REF)

Auto-refresh uses the internal refresh address counter. The SDRAM Auto-refresh command (REF) generates Precharge command internally. All banks of SDRAM should be precharged prior to the Auto-refresh command. The Auto-refresh command should also be asserted every 16 μ s or a total 2,048 refresh commands within a 32.8 ms period.

SELF-REFRESH ENTRY (SELF)

Self-refresh function provides automatic refresh by an internal timer as well as Auto-refresh and will continue the refresh function until cancelled by SELFX.

The Self-refresh is entered by applying an Auto-refresh command in conjunction with CKE = Low (SELF). Once SDRAM enters the self-refresh mode, all inputs except for CKE will be "don't care" (either logic high or low level state) and outputs will be in a High-Z state. During a self-refresh mode, CKE = Low should be maintained. SELF command should only be issued after last read data has been appeared on DQ.

SELF-REFRESH EXIT (SELFX)

To exit self-refresh mode, apply minimum 4 clock cycle before CKE brought high, and then the NOP command (NOP) or Deselect command (DESL) should be asserted within one tro period. CKE should be held High within one tro period after tribe. Refer to Timing Diagram for the detail.

It is recommended to assert an Auto-refresh command just after the tree period to avoid the violation of refresh period.

MODE REGISTER SET (MRS)

The mode register of SDRAM provides a variety of different operations. The register consists of four operation fields; Burst Length, Burst Type, CAS latency, and Operation Code. Refer to MODE REGISTER TABLE in page 32.

The mode register can be programmed by the Mode Register Set command (MRS). Each field is set by the address line. Once a mode register is programmed, the contents of the register will be held until re-programmed by another MRS command (or part loses power).

MRS command should only be issued on condition that all DQ is in High-Z.

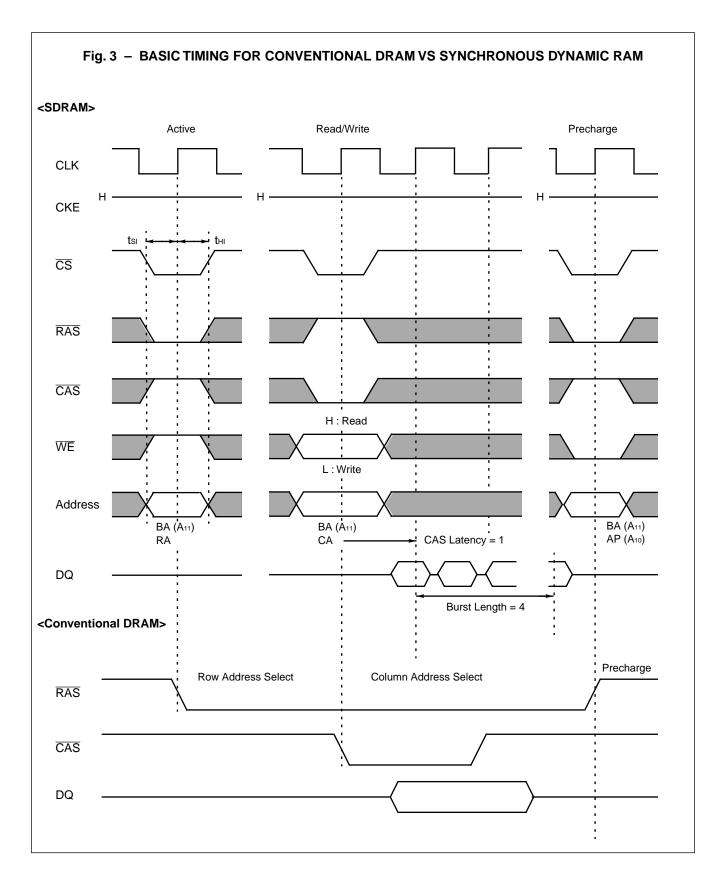
The condition of the mode register is undefined after the power-up stage. It is required to set each field after initialization of SDRAM. Refer to POWER-UP INITIALIZATION below.

POWER-UP INITIALIZATION

The SDRAM internal condition after power-up will be undefined. It is required to follow the following Power On Sequence to execute read or write operation.

- 1. Apply power and start clock. Attempt to maintain either NOP or DESL command at the input.
- 2. Maintain stable power, stable clock, and NOP condition for a minimum of 200 μs.
- 3. Precharge all banks by Precharge (PRE) or Precharge All command (PALL).
- 4. Assert minimum of 8 Auto-refresh command (REF).
- 5. Program the mode register by Mode Register Set command (MRS).

In addition, it is recommended DQM and CKE to track Vcc to insure that output is High-Z state. The Mode Register Set command (MRS) can be set before 8 Auto-refresh command (REF).



■ CAPACITANCE

 $(T_A = 25^{\circ}C, f = 1 \text{ MHz})$

Parameter	Symbol	Тур.	Max.	Unit
Input Capacitance, Address	C _{IN1}	_	4	pF
Input Capacitance, Except for address	C _{IN2}	_	4	pF
I/O Capacitance	C _{I/O}	_	7	pF

■ RECOMMENDED OPERATING CONDITIONS (Referenced to Vss)

Parameter	Notes	Symbol	Min.	Тур.	Max.	Unit
Supply Voltage		Vcc, Vccq	3.0	3.3	3.6	V
Supply Voltage		Vss, Vssq	0	0	0	V
Input High Voltage	*1	ViH	2.0	_	Vcc + 0.5	V
Input Low Voltage	*2	VIL	-0.5	_	0.8	V
Ambient Temperature	-	TA	0	_	70	°C

Notes: *1. Overshoot limit : V_{IH} (max) = TBD.

*2. Undershoot limit : V_{IL} (min) = -1.5 V with a pulsewidth ≤ 5 ns.

■ DC CHARACTERISTICS

(At recommended operating conditions unless otherwise noted.)

Notes 1, 2

1	oponaming commine		s otherwise noted.)	Mores			
Doro		Cumbal	Canditian	Va	lue	I Incit	
Para	meter	Symbol	Condition	Min.	Max.	Unit	
Output High Voltage		V _{OH(DC)}	Iон = −2 mA	2.4	_	V	
Output Low Voltage		Vol(DC)	IoL = 2 mA	_	0.4	V	
Input Leakage Curre	nt (Any Input)	lu	$0 \text{ V} \le \text{V}_{\text{IN}} \le \text{V}_{\text{CC}};$ All other pins not under test = 0 V	-10	10	μА	
Output Leakage Curr	ent	ILO	0 V ≤ V _{IN} ≤ V _{CC} ; Data out disabled	-10	10	μА	
MB81117822A-125			No Burst ;		90		
	MB81117822A-100	1.	tck = min		85		
	MB81117822A-84	- Icc1s	trc = min One bank active	_	80	⊢ mA	
Operating Current	MB81117822A-67		0 V ≤ VIN ≤ VCC		75		
(Average Power Supply Current)	MB81117822A-125		No Burst ;		140	mA	
	MB81117822A-100	1.	tck = min		130	IIIA	
	MB81117822A-84	- Icc1D	trc = min All banks active	_	120	A	
	MB81117822A-67		0 V ≤ Vin ≤ Vcc		110	⊢ mA	
Precharge Standby C		ICC2P	$CKE = V_{IL}$ All banks idle $t_{CK} = min$ Power down mode $0 \ V \le V_{IN} \le V_{CC}$	_	2	mA	
(Power Supply Curre	nt)	ICC2N	$ \begin{array}{l} CKE = V_{IH} \\ All \ banks \ idle \\ t_{CK} = min \\ 0 \ V \leq V_{IN} \leq V_{CC} \end{array} $	_	30	mA	
Active Standby Curre	ent	Іссзр	$ \begin{array}{l} CKE = V_{IL} \\ Any \ bank \ Active \\ tc\kappa = min \\ 0 \ V \leq V_{IN} \leq V_{CC} \end{array} $	_	30	mA	
(Power Supply Current)		Іссзи	$ \begin{array}{l} CKE = V_{IH} \\ Any \ bank \ Active \\ t_{CK} = min \\ 0 \ V \leq V_{IN} \leq V_{CC} \end{array} $	_	50	mA	
	MB81117822A-125				150		
Burst mode Current	MB81117822A-100	1.	tcк = min	_	135		
(Average Powr Supply Current)	MB81117822A-84	- Icc4	0 V ≤ V _{IN} ≤ V _{CC}		125	⊢ mA	
,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	MB81117822A-67	1		_	115		

Para	Parameter		Condition	Va	Unit	
raianietei		Symbol	Condition	Min.	Max.	Unit
Refresh Current #1 (Average Power Supply Current)	MB81117822A-125		Auto-refresh ;		120	
	MB81117822A-100	1.	tck = min		110	mA
	MB81117822A-84	ICC5	trc = min trrd = min	_	100	111/
	MB81117822A-67		0 V ≤ Vin ≤ Vcc		90	
Refresh Current #2 (Average Power Supply Current)		Icc ₆		_	2	mA

■ AC CHARACTERISTICS

(At recommended operating conditions unless otherwise noted.)

Notes 2, 3, 4

Parame	ter Notes	Sym- bol	MB811 -1	17822A 25		17822A 00		17822A 84	MB81117822A -67		Unit
		DOI	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
Clock Period	CAS Latency = 2	t _{ck}	12		15		17		20		ns
Clock Fellou	CAS Latency = 3	L CK	8	_	10		12		15	_	ns
Clock High Tin	ne	t cH	3.5	_	4	_	4	_	4	_	ns
Clock Low Tim	ne	t cL	3.5	_	4	_	4	_	4	_	ns
Input Set Up T	ime	t sı	3	_	3	_	3	_	3	_	ns
Input Hold Tim	ne	tнı	1	_	1	_	1	_	1	_	ns
Acess Time from Clock	CAS Latency = 2	tac		9		9		9		10	ns
(tck = min) *5,6	CAS Latency = 3	LAC		7.5		8.5		8.5		9	ns
Output in Low-	-Z	tolz	2	_	3	_	3	_	3	_	ns
Output in High	ı-Z *7	t onz	2	_	3		3		3	_	ns
Output Hold T	Output Hold Time		2	_	3	_	3	_	3	_	ns
Time between Refresh		t _{REF}	_	32.8	_	32.8	_	32.8	_	32.8	ms
Transition Time		t⊤	0.5	2	0.5	2	0.5	2	0.5	2	ns
Power Down E	xit Time	t PDE	3	_	3	_	4	_	5	_	ns

BASE VALUES FOR CLOCK COUNT / LATENCY

Parameter	Notes	Sym-		17822A 25		17822A 00		17822A 84		17822A 67	Unit
		bol	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
RAS Cycle Time	*8	t rc	75	_	90	_	100	_	110	_	ns
RAS Access Time	*9	t rac	_	45	_	54	_	56	_	60	ns
CAS Access Time	*10,13	tcac	_	21	_	24	_	26	_	30	ns
RAS Precharge Time		t RP	27	_	30	_	35	_	40	_	ns
RAS Active Time		tras	48	100000	60	100000	65	100000	70	100000	ns
RAS to CAS Delay Time	*11	t RCD	24	_	30	_	30	_	30	_	ns
Write Recovery		t wr	8	_	10	_	12	_	15	_	ns
Write to Precharge Delay	y Time	trwL	8	_	10	_	12	_	15	_	ns
RAS to RAS Bank Active Delay Time)	t rrd	24	_	30	_	30	_	30	_	ns

CLOCK COUNT FORMULA Note 13

 $\begin{tabular}{ll} Clock \geq & \underline{ & Base\ Value \\ \hline & Clock\ Period \\ \end{tabular}} & (Round\ off\ a\ whole\ number) \\ \end{tabular}$

LATENCY-FIXED VALUES

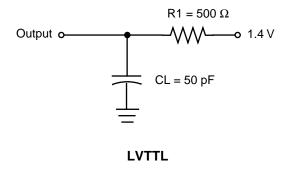
(The latency values on these parameters are fixed regardless of clock period.)

Parameter	Notes	Sym- bol	MB81117822A -125	MB81117822A -100	MB81117822A -87	MB81117822A -67	Unit
CKE to Clock Disable		Іске	1	1	1	1	cycle
DQM to Output in High-Z		ldQZ	2	2	2	2	cycle
DQM to Input Data Delay		IDQD	0	0	0	0	cycle
Last Output to Write Command Delay		lowd	2	2	2	2	cycle
Write Command to Input Data Delay		I DWD	0	0	0	0	cycle
Precharge to Output in High-Z Delay	CL = 2	Ігон	2	2	2	2	cycle
	CL = 3		3	3	3	3	cycle
Burst Stop Command to Output in High-Z Delay	CL = 2	Івѕн	2	2	2	2	cycle
	CL = 3		3	3	3	3	cycle
Mode Register Access to Bank Active		I MRD	2	2	2	2	cycle
CAS to CAS Delay (min)		Іссь	1	1	1	1	cycle
CAS Bank Delay (min)		ICBD	1	1	1	1	cycle

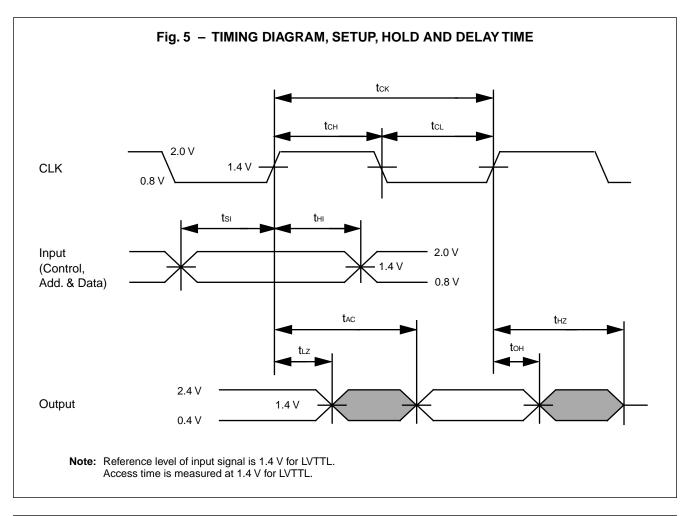
Notes: *1. Icc depends on the output termination or load conditions, clock cycle rate, and signal clocking rate; The specified values are obtained with the output open and no termination register.

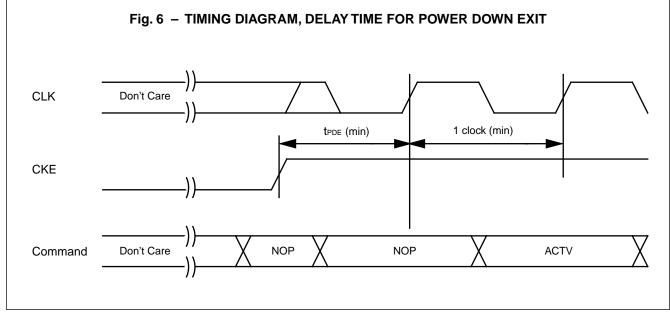
- * 2. An initial pause (DESL or NOP) of 200 μs is required after power-up followed by a minimum of eight Auto Refresh cycles.
- *3. AC characteristics assume $t_T = 1$ ns and 30 pF of capacitive load.
- *4. 1.4 V is the reference level for measuring timing of input signals. Transition times are measured between V_{IH} (min) and V_{IL} (max).
- *5. Assumes trcd and tcac are satisfied.
- *6. tac also specifies the access time at burst mode except for first access.
- *7. Specified where output buffer is no longer driven.
- *8. Actual clock count of trc (Irc) will be sum of clock count of tras (Iras) and trp (Irp).
- *9. trac is a reference value. Maximum value is obtained from the sum of trac (min) and trac (max).
- *10. Assumes trac and tac are satisfied.
- *11. Operation within the trcd (min) ensures that trac can be met; if trcd is greater than the specified trcd (min), access time is determined by trac or trac.
- *12. All base values are measured from the clock edge at the command input to the clock edge for the next command input. All clock counts are calculated by a simple formula: clock count equals base value divided by clock period (round off to a whole number).
- *13. The tcac is programmed by the mode register.

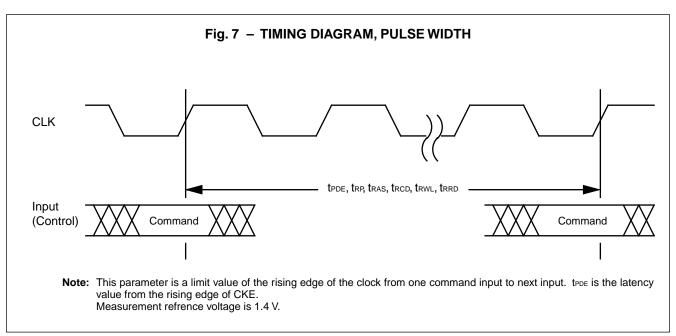
Fig. 4 - EXAMPLE OF ACTEST LOAD CIRCUIT

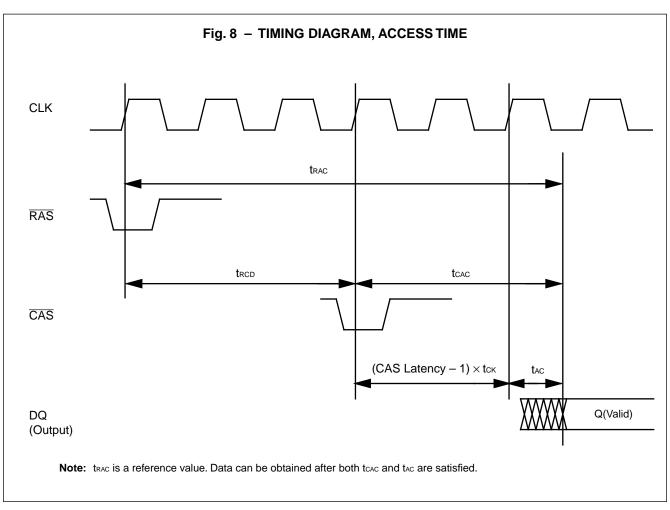


Note: AC characteristics are measured in this condition. This load circuits are not applicable for VoH and VoL.

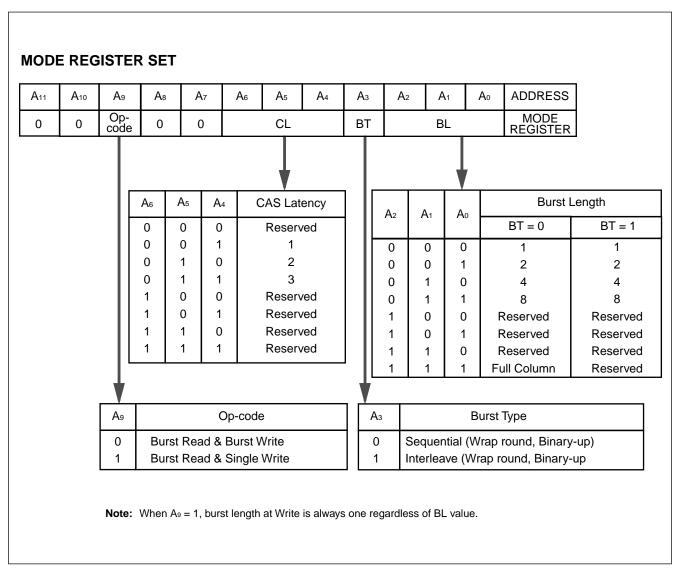


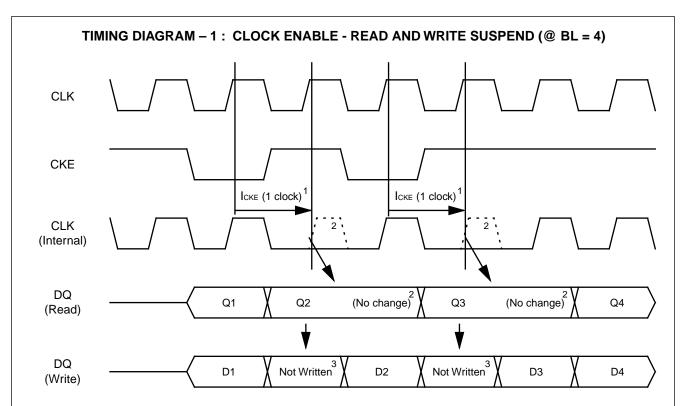




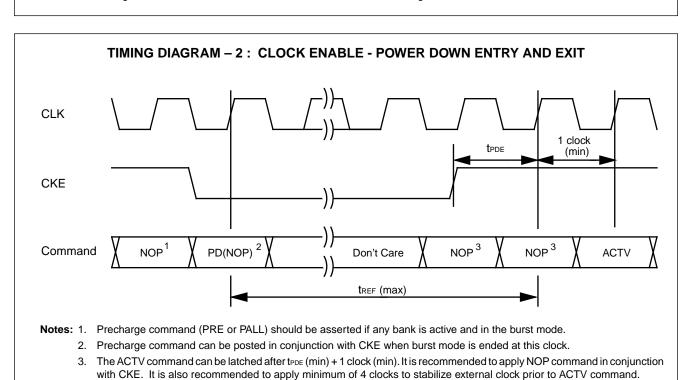


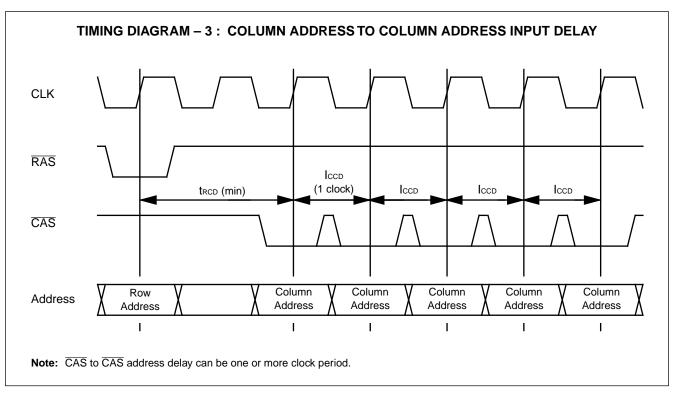
■ MODE REGISTER TABLE

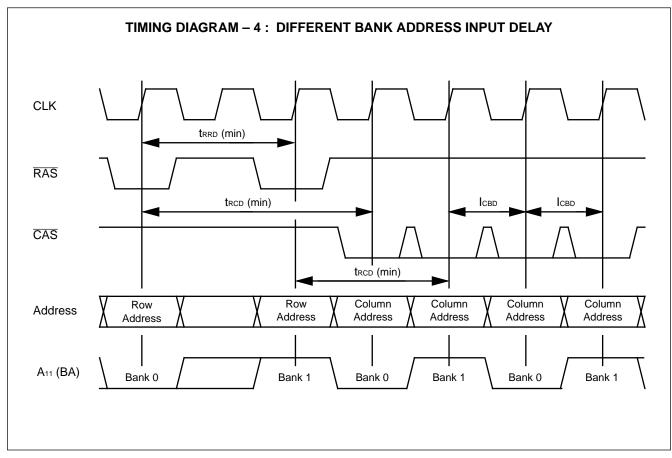


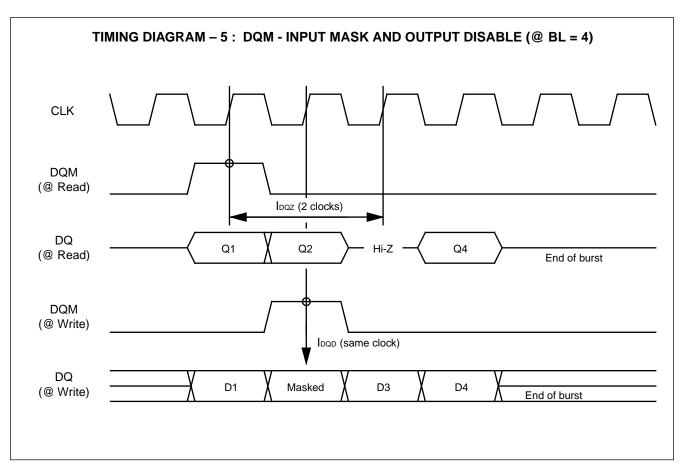


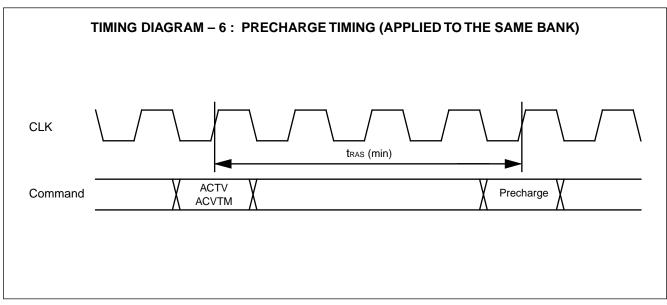
- Notes: 1. The latency of CKE (ICKE) is one clock.
 - During read mode, burst counter will not be incremented at the next clock of CSUS command. Output remain the same data
 - 3. During the write mode, data at the next clock of CSUS command is ignored.

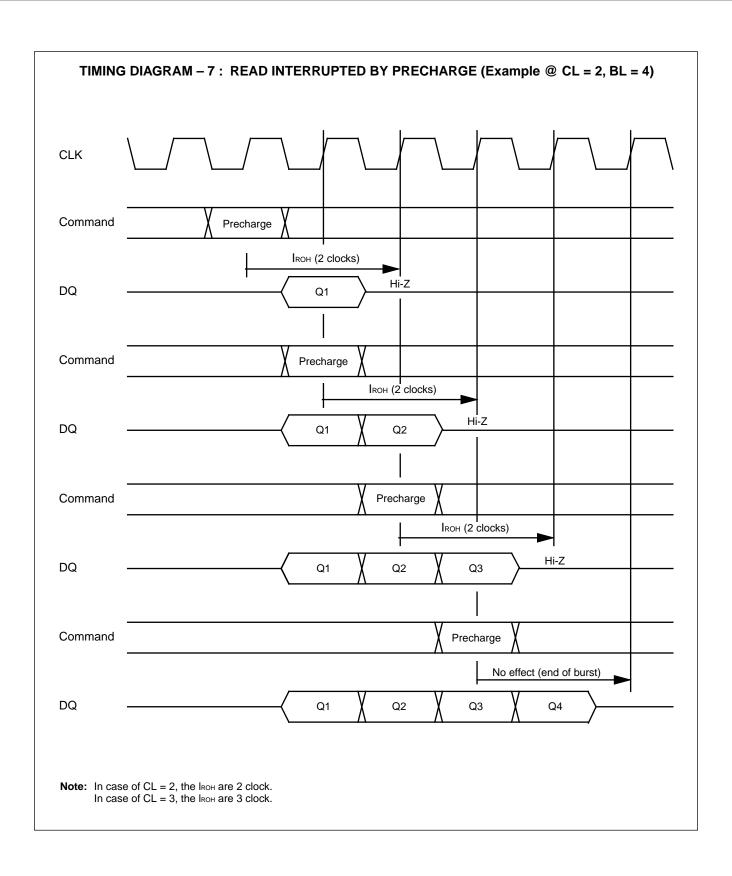


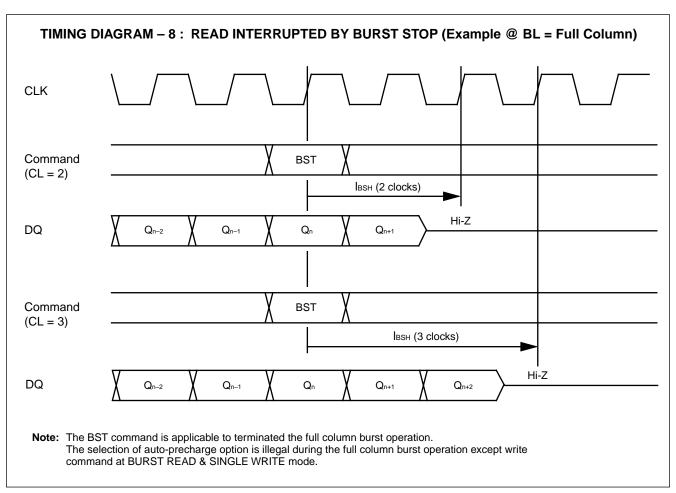


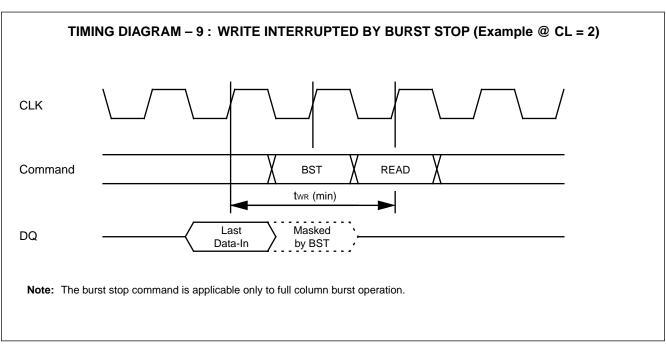


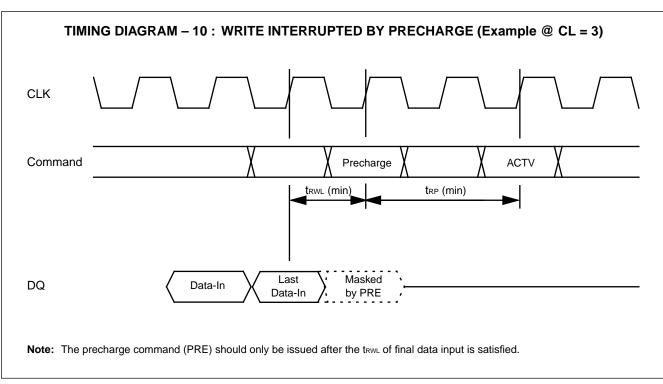


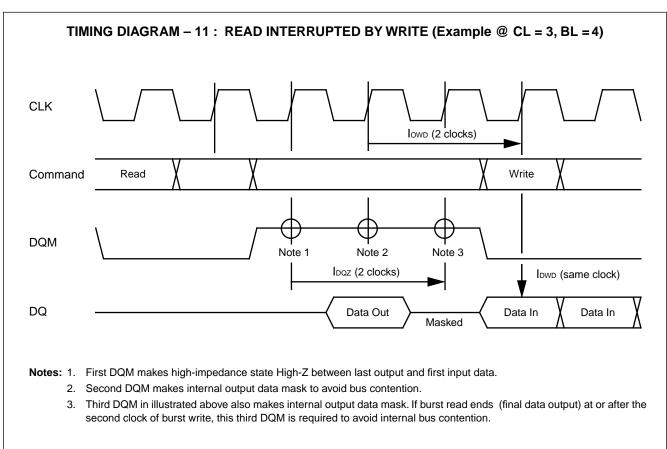


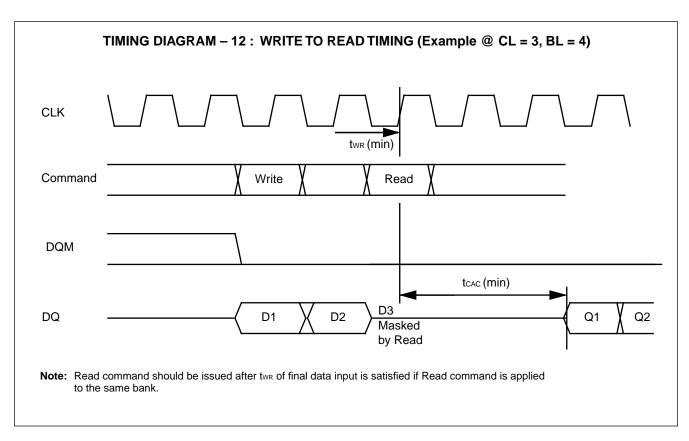


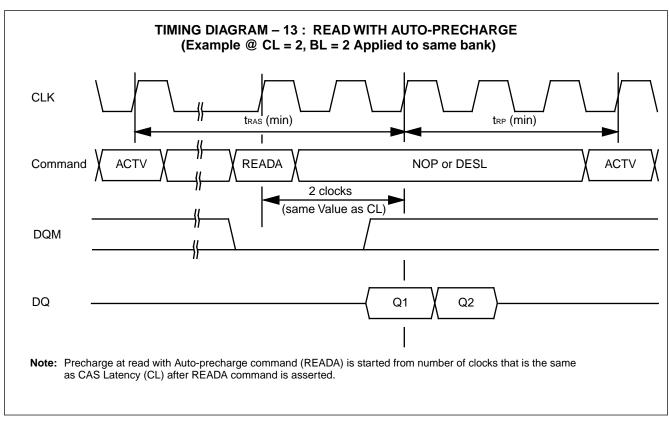


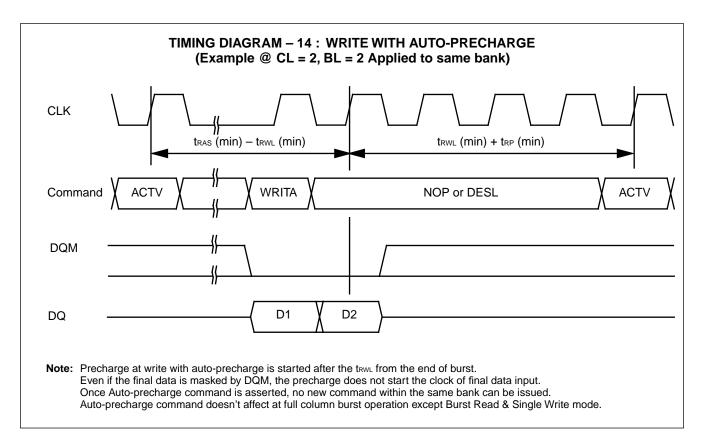


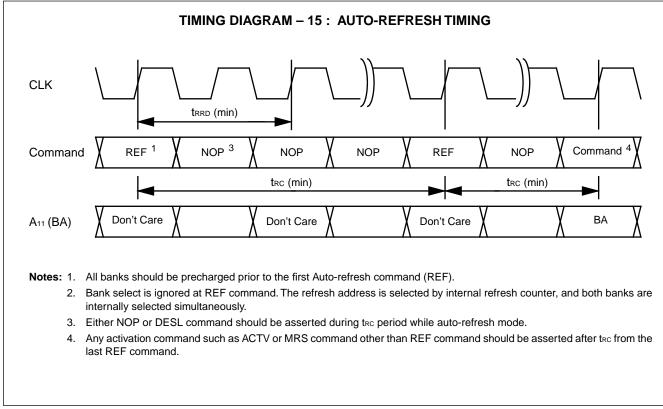


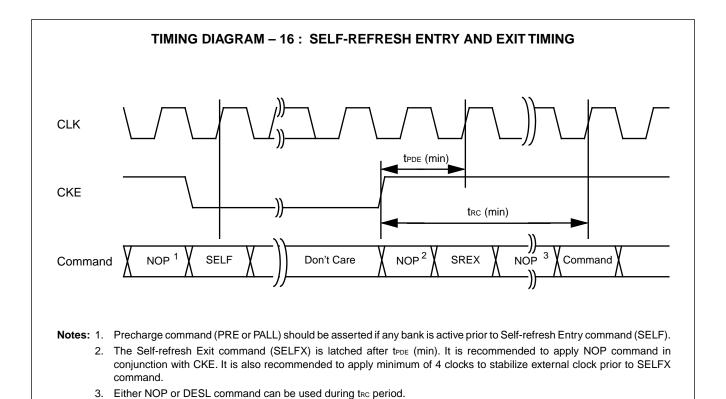


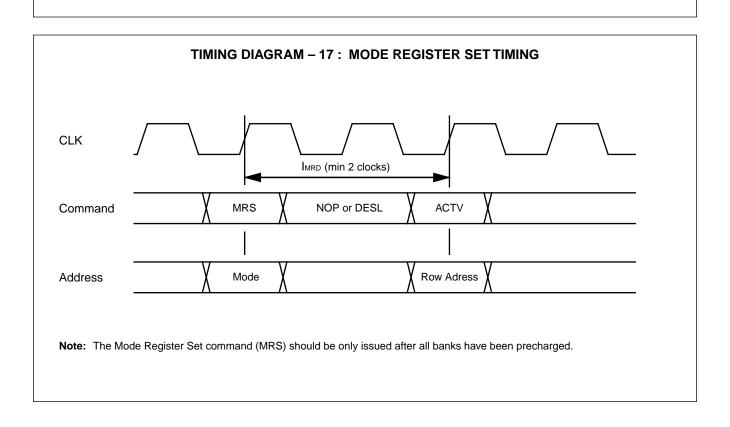




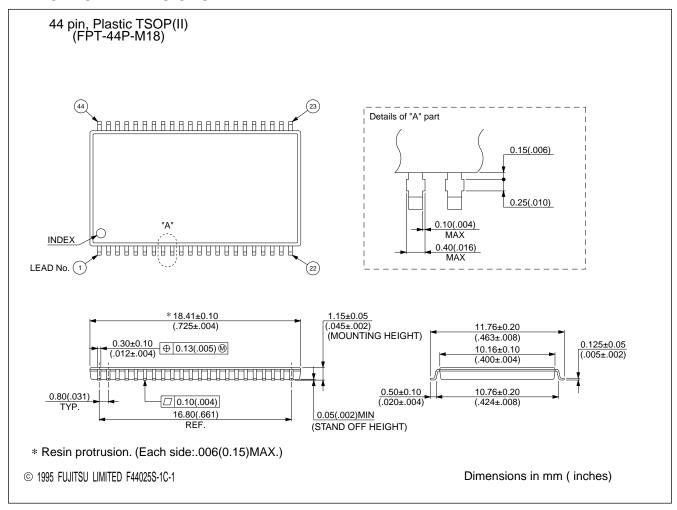








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